

MOSFET - Power, Single N-Channel, STD Gate, SO8FL

80 V, 3.5 mΩ, 119 A

NTMFS4D0N08X

Features

- Low Q_{RR}, Soft Recovery Body Diode
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Synchronous Rectification (SR) in DC-DC and AC-DC
- Primary Switch in Isolated DC-DC Converter
- Motor Drives

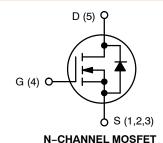
MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	V_{DSS}	80	V	
Gate-to-Source Voltage	V_{GS}	±20	V	
Continuous Drain Current T _C = 25°C		I _D	119	Α
(Note 1)	T _C = 100°C		84	
Power Dissipation (Note 1)	T _C = 25°C	P_{D}	107	W
Pulsed Drain Current	T _C = 25°C,	I _{DM}	469	Α
Pulsed Source Current (Body Diode)	t _p = 100 μs	I _{SM}	469	
Operating Junction and Storage Range	T _J , T _{STG}	-55 to +175	°C	
Source Current (Body Diode)	IS	162	Α	
Single Pulse Avalanche Energy (I _{PK} = 44 A) (Note 3)	E _{AS}	97	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T _L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 in² pad size, 1 oz. Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3. E_{AS} of 97 mJ is based on started TJ = 25 C, I_{AS} = 44 A, V_{DD} = 64 V, V_{GS} = 10 V, 100% avalanche tested.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
80 V	3.5 m Ω @ 10 V	119 A



MARKING DIAGRAM



DFN5 (SO-8FL) CASE 488AA



4D0N08 = Specific Device Code

= Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 3 of this data sheet.

THERMAL CHARACTERISTICS

Parameter		Value	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	1.4	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	39	

Surface–mounted on FR4 board using 1 in² pad, 1 oz. Cu.
 R_{JA} is determined by the user's board design.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS					1	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	ΔV _{(BR)DSS} / ΔΤ _J	I _D = 1 mA, Referenced to 25°C		31.7		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V, T _J = 25°C			1	μΑ
		V _{DS} = 80 V, T _J = 125°C			250	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 20 V, V _{DS} = 0 V			100	nA
ON CHARACTERISTICS						
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 27 \text{ A}$		3.0	3.5	mΩ
		V _{GS} = 6 V, I _D = 13 A		4.8	6.4	
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 133 \mu A$	2.4		3.6	V
Gate Threshold Voltage Temperature Coefficient	$\Delta V_{GS(TH)}/ \Delta T_J$	$V_{GS} = V_{DS}$, $I_D = 133 \mu A$		-7.5		mV/°C
Forward Transconductance	9FS	V _{DS} = 5 V, I _D = 27 A		85		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE					
Input Capacitance	C _{ISS}			2400		pF
Output Capacitance	C _{OSS}	\\		700		
Reverse Transfer Capacitance	C _{RSS}	$V_{GS} = 0 \text{ V}, V_{DS} = 40 \text{ V}, f = 1 \text{ MHz}$		11		
Output Charge	Q _{OSS}			50		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 6 V, V _{DD} = 40 V, I _D = 27 A		21		
				33		nC
Threshold Gate Charge	Q _{G(TH)}			7		
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 10 \text{ V}, V_{DD} = 40 \text{ V}, I_D = 27 \text{ A}$		11		
Gate-to-Drain Charge	Q_{GD}			5		
Gate Plateau Voltage	V _{GP}			4.7		V
Gate Resistance	R_{G}	f = 1 MHz		0.7		Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(ON)}			21		ns
Rise Time	t _r	Resistive Load,		6		
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 0/10 \text{ V}, V_{DD} = 40 \text{ V},$ $I_{D} = 27 \text{ A}, R_{G} = 2.5 \Omega$		30		
Fall Time	t _f			5		
SOURCE-TO-DRAIN DIODE CHARACTI	ERISTICS					
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_S = 27 \text{ A}, T_J = 25^{\circ}\text{C}$		0.82	1.2	V
		V _{GS} = 0 V, I _S = 27 A, T _J = 125°C		0.66		Ĭ

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SOURCE-TO-DRAIN DIODE CHARACTERISTICS						
Reverse Recovery Time	t _{RR}			21		ns
Charge Time	t _a	V_{GS} = 0 V, dl/dt = 1000 A/ μ s, I_{S} = 27 A, V_{DD} = 40 V		11		
Discharge Time	t _b			10		
Reverse Recovery Charge	Q_{RR}			130		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTMFS4D0N08XT1G	4D0N08	DFN5 (Pb-Free)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

TYPICAL CHARACTERISTICS

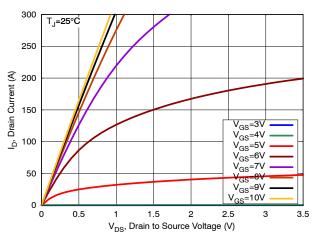


Figure 1. On-Region Characteristics

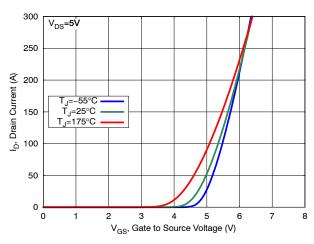


Figure 2. Transfer Characteristics

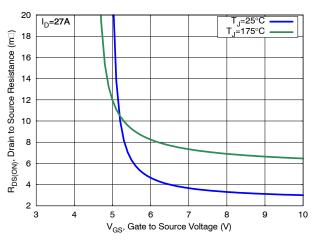


Figure 3. On-Resistance vs. Gate Voltage

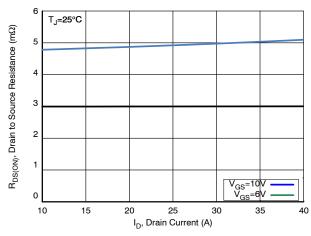
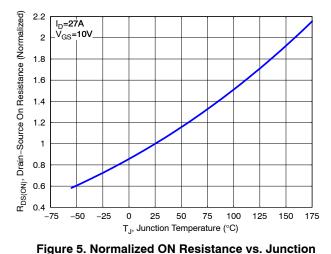


Figure 4. On-Resistance vs. Drain Current



Temperature

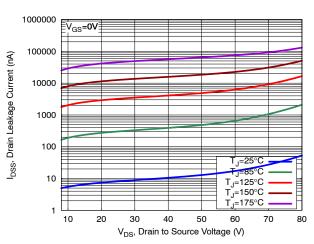


Figure 6. Drain Leakage Current vs. Drain Voltage

TYPICAL CHARACTERISTICS

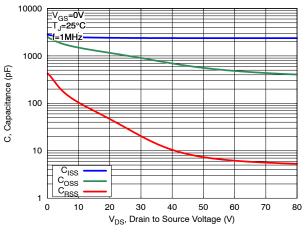


Figure 7. Capacitance Characteristics

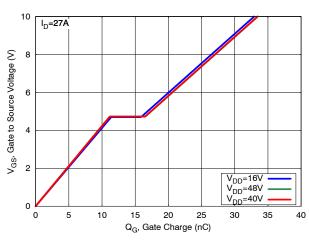


Figure 8. Gate Charge Characteristics

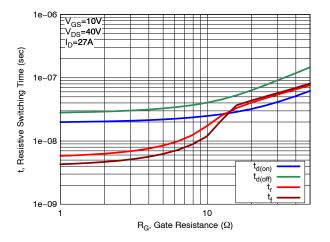


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

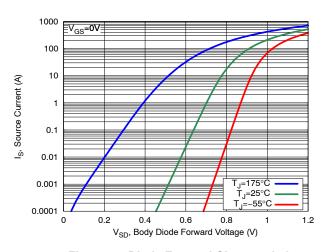


Figure 10. Diode Forward Characteristics

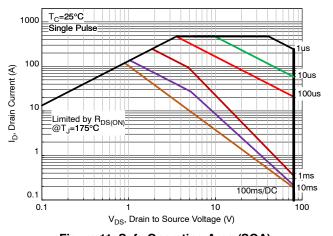


Figure 11. Safe Operating Area (SOA)

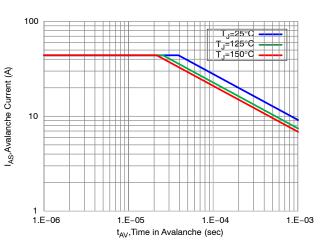
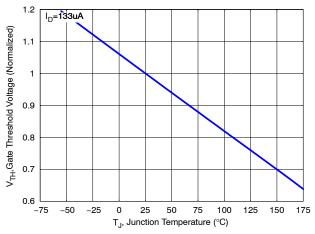


Figure 12. Avalanche Current vs Pulse Time (UIS)

TYPICAL CHARACTERISTICS



120 100 (£) 80 100 60 20 25 50 75 100 125 150 175 T_C, Case Temperature (°C)

Figure 13. Gate Threshold Voltage vs Junction Temperature

Figure 14. Maximum Current vs. Case Temperature

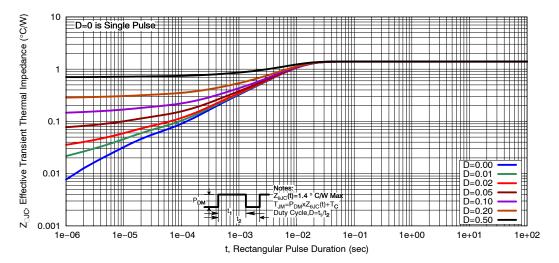


Figure 15. Transient Thermal Response





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.00		0.05	
b	0.33	0.41	0.51	
С	0.23	0.28	0.33	
D	5.00	5.15	5.30	
D1	4.70	4.90	5.10	
D2	3.80	4.00	4.20	
E	6.00	6.15	6.30	
E1	5.70	5.90	6.10	
E2	3.45	3.65	3.85	
е	1.27 BSC			
G	0.51	0.575	0.71	
K	1.20	1.35	1.50	
L	0.51	0.575	0.71	
L1	0.125 REF			
M	3.00	3.40	3.80	
θ	0 °		12 °	

GENERIC MARKING DIAGRAM*

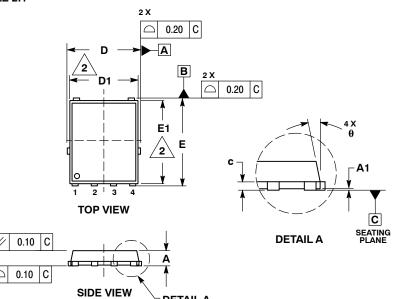


XXXXXX = Specific Device Code

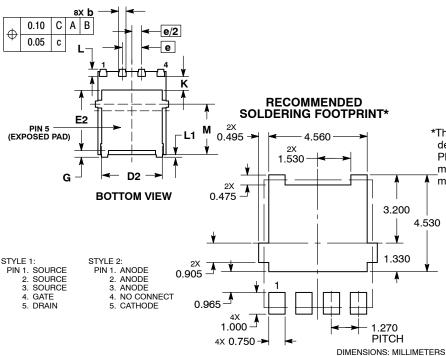
= Assembly Location Α

Υ = Year W = Work Week = Lot Traceability ZZ

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.



DETAIL A



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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